

# NB3H83905C

## 1.8V/2.5V/3.3V Crystal Input to 1:6 LVTTL/LVCMOS Clock Fanout Buffer with OE

### Description

The NB3H83905C is a 1.8 V, 2.5 V or 3.3 V  $V_{DD}$  core Crystal input to 1:6 LVTTL/LVCMOS fanout buffer with outputs powered by flexible 1.8 V, 2.5 V, or 3.3 V supply  $V_{DDO}$  (with  $V_{DD} \geq V_{DDO}$ ). The device accepts a fundamental Parallel Resonant crystal from 3 MHz to 40 MHz or a single-ended LVCMOS Clock from up to 100 MHz.

Two synchronous LVTTL/LVCMOS Enable lines permit independent control over outputs BCLK[0:4] and output BCLK5; enabling or disabling only when the output is in LOW state eliminating potential output glitching or runt pulse generation. When unused, leave floating open, pins will default to HIGH state.

The 6 outputs drive 50  $\Omega$  series or parallel terminated transmission lines. Parallel termination should be to  $1/2 V_{CC}$ . Series terminated lines can drive 2 loads each, or 12 lines total.

Fit, Form, and Function compatible with ICS83905 and PI6C10806.

### Features

- Six Copies of LVTTL/LVCMOS Output Clock
- Supply Operation  $V_{DD} \geq V_{DDO}$ :
  - ♦ 1.8 V  $\pm 0.2$  V, 2.5 V  $\pm 5\%$  or 3.3 V  $\pm 5\%$  Core  $V_{DD}$
  - ♦ 1.8 V  $\pm 0.2$  V, 2.5 V  $\pm 5\%$ , or 3.3 V  $\pm 5\%$  Output  $V_{DDO}$
- Crystal Oscillator Interface
- Crystal Input Frequency Range: 3 MHz to 40 MHz
- Clock Input Frequency Range: Up to 100 MHz
- LVCMOS compatible Enable Inputs
- 5 V Tolerant Enable Inputs
- Low Output to Output Skew: 80 ps Max
- Synchronous Output Enable
- Phase Noise Floor -160 dBc (1 MHz)
- Industrial Temperature Range
- These are Pb-Free Devices

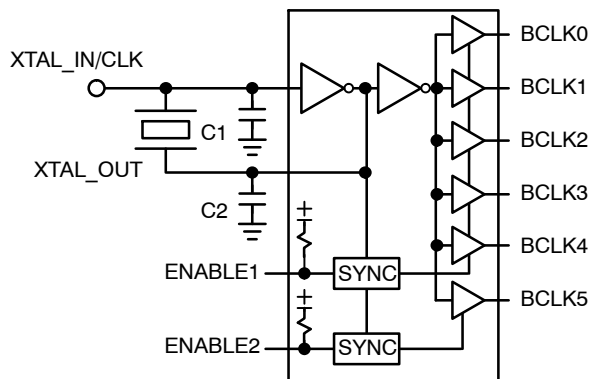


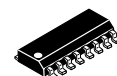
Figure 1. Simplified Block Diagram



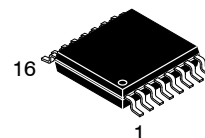
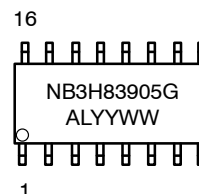
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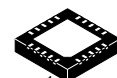
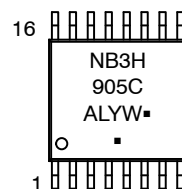
### MARKING DIAGRAMS\*



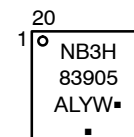
SOIC-16  
D SUFFIX  
CASE 751B



TSSOP-16  
DT SUFFIX  
CASE 948F



QFN20  
MN SUFFIX  
CASE 485BH



A = Assembly Location  
L = Wafer Lot  
YY, Y = Year  
WW, W = Work Week  
G or ■ = Pb-Free Package

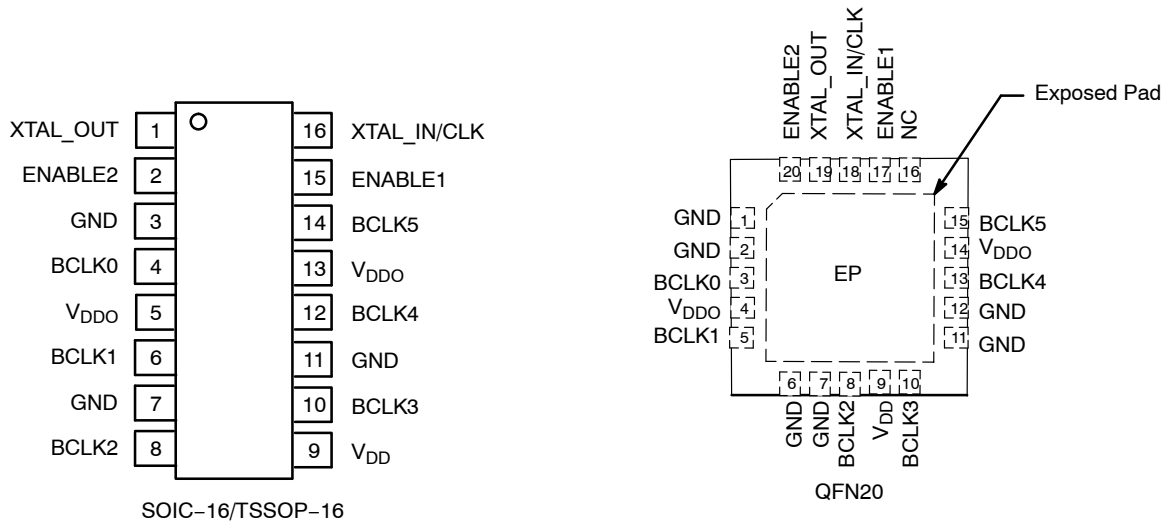
(\*Note: Microdot may be in either location)

\*For additional marking information, refer to Application Note AND8002/D.

### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 11 of this data sheet.

# NB3H83905C



**Figure 2. Pinout Configuration (Top View)**

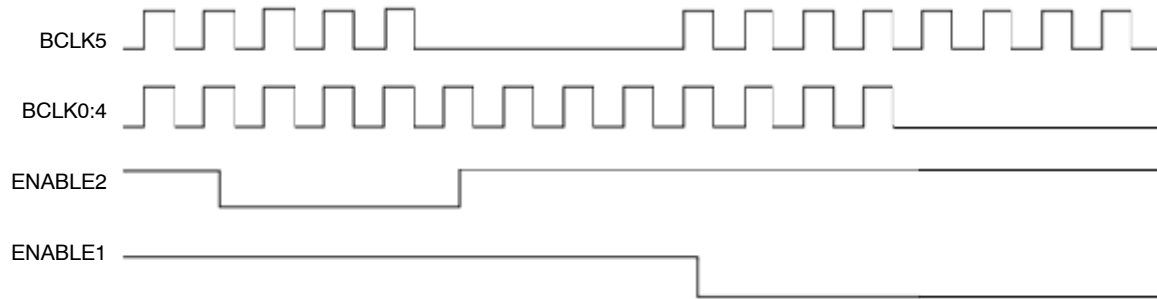
**Table 1. PIN DESCRIPTION**

| SOIC-16 / TSSOP-16  | QFN-20              | Name                 | I/O                    | Description                                                                                                                                                                                                                                                                                                                        |
|---------------------|---------------------|----------------------|------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 1                   | 19                  | XTAL_OUT             | Crystal Interface      | Oscillator Output to drive Crystal                                                                                                                                                                                                                                                                                                 |
| 2                   | 20                  | ENABLE 2             | LVTTTL / LVC MOS Input | Synchronous Enable Input for BCLK5 Output. Switches only when HIGH. Open default condition HIGH due to an internal pullup resistor to V <sub>CC</sub> .                                                                                                                                                                            |
| 3, 7, 11            | 1, 2, 6, 7, 11, 12  | GND                  | GND                    | GND Supply pins. All GND, V <sub>DD</sub> and V <sub>DDO</sub> pins must be externally connected to power supply to guarantee proper operation.                                                                                                                                                                                    |
| 4, 6, 8, 10, 12, 14 | 3, 5, 8, 10, 13, 15 | BCLK0, 1, 2, 3, 4, 5 | LVC MOS Outputs        | Buffered Clock Outputs                                                                                                                                                                                                                                                                                                             |
| 5, 13               | 4, 14               | V <sub>DDO</sub>     | POWER                  | Positive Supply voltage for outputs. All GND, V <sub>DD</sub> and V <sub>DDO</sub> pins must be externally connected to power supply to guarantee proper operation. Bypass with 0.01 $\mu$ F cap to GND.                                                                                                                           |
| 9                   | 9                   | V <sub>DD</sub>      | POWER                  | Positive Supply voltage for core. All GND, V <sub>DD</sub> and V <sub>DDO</sub> pins must be externally connected to power supply to guarantee proper operation. Bypass with 0.01 $\mu$ F cap to GND.                                                                                                                              |
| –                   | 16                  | NC                   |                        | No Connect                                                                                                                                                                                                                                                                                                                         |
| 15                  | 17                  | ENABLE 1             | LVTTTL / LVC MOS Input | Synchronous Enable Input for BCLK0/1/2/3/4 Output block. Switches only when HIGH. Open default condition HIGH due to an internal pullup resistor to V <sub>CC</sub>                                                                                                                                                                |
| 16                  | 18                  | XTAL_IN/CLK          | Crystal Interface      | Oscillator Input from Crystal. Single ended Clock Input.                                                                                                                                                                                                                                                                           |
| –                   | EP                  |                      | –                      | The Exposed Pad (EP) on the QFN-20 package bottom is thermally connected to the die for improved heat transfer out of package. The exposed pad must be attached to a heat-sinking conduit. The pad is not electrically connected to the die, but is recommended to be electrically and thermally connected to GND on the PC board. |

**Table 2. CLOCK ENABLE FUNCTION TABLE**

| Control Inputs |          | Outputs     |          |
|----------------|----------|-------------|----------|
| ENABLE1*       | ENABLE2* | BCLK0:BCLK4 | BCLK5    |
| 0              | 0        | LOW         | LOW      |
| 0              | 1        | LOW         | Toggling |
| 1              | 0        | Toggling    | LOW      |
| 1              | 1        | Toggling    | Toggling |

\*Defaults HIGH when floating open.

**Figure 3. ENABLEx Control Timing Diagram**

The ENABLEx control inputs will synchronously enable or disable the selected output(s). This control detects the falling edge of the internal signal and asserts or de-asserts the output after 3 clock cycles. When ENABLEx is LOW, the outputs are disabled to a LOW state. When ENABLEx is HIGH, the outputs are enabled to toggle.

**Table 3. RECOMMENDED CRYSTAL PARAMETERS**

|                              |                    |
|------------------------------|--------------------|
| Crystal                      | Fundamental AT-Cut |
| Frequency                    | 10 to 40 MHz       |
| Load Capacitance*            | 16–20 pF           |
| Shunt Capacitance, C0        | 7 pF Max           |
| Equivalent Series Resistance | 50 $\Omega$ Max    |
| Drive Level                  | 1 mW               |

\*See APPLICATION INFORMATION; Crystal Input Interface for CL loading

**Table 4. ATTRIBUTES** (Note 1)

| Characteristics                                               | Value                             |
|---------------------------------------------------------------|-----------------------------------|
| ESD Protection Human Body Model<br>Machine Model              | > 2 kV<br>> 200 V                 |
| Moisture Sensitivity, Indefinite Time Out of Drypack (Note 1) | Level 1                           |
| Flammability Rating<br>Oxygen Index                           | UL-94 code V-0 A 1/8"<br>28 to 34 |
| Transistor Count                                              | 213 Devices                       |
| Meets or exceeds JEDEC Spec EIA/JESD78 IC Latchup Test        |                                   |

1. For additional information, see Application Note AND8003/D.

**Table 5. MAXIMUM RATINGS** (Note 2)

| Symbol        | Parameter                                | Condition 1        | Condition 1          | Rating                            | Unit |
|---------------|------------------------------------------|--------------------|----------------------|-----------------------------------|------|
| $V_{DDx}$     | Positive Power Supply                    | GND = 0 V          |                      | 4.6                               | V    |
| $V_I$         | Input Voltage                            |                    |                      | $-0.5 \leq V_I \leq V_{DD} + 0.5$ | V    |
| $T_A$         | Operating Temperature Range, Industrial  |                    |                      | -40 to $\leq$ +85                 | °C   |
| $T_{stg}$     | Storage Temperature Range                |                    |                      | -65 to +150                       | °C   |
| $\theta_{JA}$ | Thermal Resistance (Junction-to-Ambient) | 0 lfpm<br>500 lfpm | SOIC-16<br>SOIC-16   | 80<br>55                          | °C/W |
| $\theta_{JC}$ | Thermal Resistance (Junction-to-Case)    | (Note 3)           | SOIC-16              | 33-36                             | °C/W |
| $\theta_{JA}$ | Thermal Resistance (Junction-to-Ambient) | 0 lfpm<br>500 lfpm | TSSOP-16<br>TSSOP-16 | 138<br>108                        | °C/W |
| $\theta_{JC}$ | Thermal Resistance (Junction-to-Case)    | (Note 3)           | TSSOP-16             | 33-36                             | °C/W |
| $\theta_{JA}$ | Thermal Resistance (Junction-to-Ambient) | 0 lfpm<br>500 lfpm | QFN-20<br>QFN-20     | 47<br>33                          | °C/W |
| $\theta_{JC}$ | Thermal Resistance (Junction-to-Case)    | (Note 3)           | QFN-20               | 18                                | °C/W |
| $T_{sol}$     | Wave Solder                              | 3 sec @ 248°C      |                      | 265                               | °C   |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and not valid simultaneously. If stress limits are exceeded device functional operation is not implied, damage may occur and reliability may be affected.
- JEDEC standard multilayer board – 2S2P (2 signal, 2 power).

Table 6. DC CHARACTERISTICS

| Symbol                                                                                                                                                                              | Characteristic                                                                   | Min                 | Typ | Max                      | Unit     |
|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------------------------------------------------------------------------------|---------------------|-----|--------------------------|----------|
| <b><math>V_{DD} = V_{DDO} = 3.135 \text{ V to } 3.465 \text{ V } (3.3 \text{ V} \pm 5\%); \text{ GND} = 0 \text{ V}, T_A = -40^\circ\text{C to } +85^\circ\text{C}</math></b>       |                                                                                  |                     |     |                          |          |
| IDD                                                                                                                                                                                 | Core Quiescent Power Supply Current (ENABLEx = LOW)                              |                     |     | 10                       | mA       |
| IDDO                                                                                                                                                                                | Output Quiescent Power Supply Current (ENABLEx = LOW)                            |                     |     | 5                        | mA       |
| V <sub>IH</sub>                                                                                                                                                                     | Input HIGH Voltage ENABLEx, XTAL_IN/CLK                                          | 2                   |     | $V_{DD} + 0.3 \text{ V}$ | V        |
| V <sub>IL</sub>                                                                                                                                                                     | Input LOW Voltage ENABLEx, XTAL_IN/CLK                                           | -0.3                |     | 0.8                      | V        |
| V <sub>OH</sub>                                                                                                                                                                     | Output HIGH Voltage (Note 4)                                                     | 2.6                 |     |                          | V        |
| V <sub>OL</sub>                                                                                                                                                                     | Output LOW Voltage (Note 4)                                                      |                     |     | 0.5                      | V        |
| C <sub>IN</sub>                                                                                                                                                                     | Input Capacitance                                                                |                     | 4   |                          | pF       |
| C <sub>PD</sub>                                                                                                                                                                     | Power Dissipation Capacitance (per Output) (Note 4)                              |                     | 19  |                          | pF       |
| R <sub>OUT</sub>                                                                                                                                                                    | Output Impedance (Note 4)                                                        |                     | 7   |                          | $\Omega$ |
| <b><math>V_{DD} = V_{DDO} = 2.375 \text{ V to } 2.625 \text{ V } (2.5 \text{ V} \pm 5\%); \text{ GND} = 0 \text{ V}, T_A = -40^\circ\text{C to } +85^\circ\text{C}</math></b>       |                                                                                  |                     |     |                          |          |
| IDD                                                                                                                                                                                 | Core Quiescent Power Supply Current (ENABLEx = LOW)                              |                     |     | 8                        | mA       |
| IDDO                                                                                                                                                                                | Output Quiescent Power Supply Current (ENABLEx = LOW)                            |                     |     | 4                        | mA       |
| V <sub>IH</sub>                                                                                                                                                                     | Input HIGH Voltage ENABLEx, XTAL_IN/CLK                                          | 1.7                 |     | $V_{DD} + 0.3 \text{ V}$ | V        |
| V <sub>IL</sub>                                                                                                                                                                     | Input LOW Voltage ENABLEx, XTAL_IN/CLK                                           | -0.3                |     | 0.7                      | V        |
| V <sub>OH</sub>                                                                                                                                                                     | Output HIGH Voltage ( $I_{OH} = -1 \text{ mA}$ )<br>Output HIGH Voltage (Note 4) | 2.0<br>1.8          |     |                          | V        |
| V <sub>OL</sub>                                                                                                                                                                     | Output LOW Voltage ( $I_{OL} = 1 \text{ mA}$ )<br>Output LOW Voltage (Note 4)    |                     |     | 0.4<br>0.45              | V        |
| C <sub>IN</sub>                                                                                                                                                                     | Input Capacitance                                                                |                     | 4   |                          | pF       |
| C <sub>PD</sub>                                                                                                                                                                     | Power Dissipation Capacitance (per Output) (Note 4)                              |                     | 18  |                          | pF       |
| R <sub>OUT</sub>                                                                                                                                                                    | Output Impedance (Note 4)                                                        |                     | 7   |                          | $\Omega$ |
| <b><math>V_{DD} = V_{DDO} = 1.6 \text{ V to } 2.0 \text{ V } (1.8 \text{ V} \pm 0.2 \text{ V}); \text{ GND} = 0 \text{ V}, T_A = -40^\circ\text{C to } +85^\circ\text{C}</math></b> |                                                                                  |                     |     |                          |          |
| IDD                                                                                                                                                                                 | Core Quiescent Power Supply Current (ENABLEx = LOW)                              |                     |     | 5                        | mA       |
| IDDO                                                                                                                                                                                | Output Quiescent Power Supply Current (ENABLEx = LOW)                            |                     |     | 3                        | mA       |
| V <sub>IH</sub>                                                                                                                                                                     | Input HIGH Voltage ENABLEx, XTAL_IN/CLK                                          | $0.65 \cdot V_{DD}$ |     | $V_{DD} + 0.3 \text{ V}$ | V        |
| V <sub>IL</sub>                                                                                                                                                                     | Input LOW Voltage ENABLEx, XTAL_IN/CLK                                           | -0.3                |     | $0.35 \cdot V_{DD}$      | V        |
| V <sub>OH</sub>                                                                                                                                                                     | Output HIGH Voltage (Note 4)                                                     | $V_{DDO} - 0.3$     |     |                          | V        |
| V <sub>OL</sub>                                                                                                                                                                     | Output LOW Voltage (Note 4)                                                      |                     |     | 0.35                     | V        |
| C <sub>IN</sub>                                                                                                                                                                     | Input Capacitance                                                                |                     | 4   |                          | pF       |
| C <sub>PD</sub>                                                                                                                                                                     | Power Dissipation Capacitance (per Output) (Note 4)                              |                     | 16  |                          | pF       |
| R <sub>OUT</sub>                                                                                                                                                                    | Output Impedance (Note 4)                                                        |                     | 10  |                          | $\Omega$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

4. Parallel terminated  $50 \Omega$  to  $V_{DDO}/2$  (see Figure 5).

Table 6. DC CHARACTERISTICS (continued)

| Symbol                                                                                                                                                | Characteristic                                                                | Min        | Typ | Max                     | Unit |
|-------------------------------------------------------------------------------------------------------------------------------------------------------|-------------------------------------------------------------------------------|------------|-----|-------------------------|------|
| <b>V<sub>DD</sub> = 3.135 V to 3.465 V (3.3 V ± 5%); V<sub>DDO</sub> = 2.375 V to 2.625 V (2.5 V ± 5%); GND = 0 V, T<sub>A</sub> = -40°C to +85°C</b> |                                                                               |            |     |                         |      |
| IDD                                                                                                                                                   | Core Quiescent Power Supply Current (ENABLEx = LOW)                           |            |     | 10                      | mA   |
| IDDO                                                                                                                                                  | Output Quiescent Power Supply Current (ENABLEx = LOW)                         |            |     | 4                       | mA   |
| V <sub>IH</sub>                                                                                                                                       | Input HIGH Voltage ENABLEx, XTAL_IN/CLK                                       | 2          |     | V <sub>DD</sub> + 0.3 V | V    |
| V <sub>IL</sub>                                                                                                                                       | Input LOW Voltage ENABLEx, XTAL_IN/CLK                                        | -0.3       |     | 0.8                     | V    |
| V <sub>OH</sub>                                                                                                                                       | Output HIGH Voltage (I <sub>OH</sub> = -1 mA)<br>Output HIGH Voltage (Note 4) | 2.0<br>1.8 |     |                         | V    |
| V <sub>OL</sub>                                                                                                                                       | Output LOW Voltage (I <sub>OL</sub> = 1 mA)<br>Output LOW Voltage (Note 4)    |            |     | 0.4<br>0.45             | V    |
| C <sub>IN</sub>                                                                                                                                       | Input Capacitance                                                             |            | 4   |                         | pF   |
| C <sub>PD</sub>                                                                                                                                       | Power Dissipation Capacitance (per Output) (Note 4)                           |            | 18  |                         | pF   |
| R <sub>OUT</sub>                                                                                                                                      | Output Impedance (Note 4)                                                     |            | 7   |                         | Ω    |

**V<sub>DD</sub> = 3.135 V to 3.465 V (3.3 V ± 5%); V<sub>DDO</sub> = 1.6 V to 2.0 V (1.8 V ± 0.2 V); GND = 0 V, T<sub>A</sub> = -40°C to +85°C**

|                  |                                                       |                       |    |                         |    |
|------------------|-------------------------------------------------------|-----------------------|----|-------------------------|----|
| IDD              | Core Quiescent Power Supply Current (ENABLEx = LOW)   |                       |    | 10                      | mA |
| IDDO             | Output Quiescent Power Supply Current (ENABLEx = LOW) |                       |    | 3                       | mA |
| V <sub>IH</sub>  | Input HIGH Voltage ENABLEx, XTAL_IN/CLK               | 2                     |    | V <sub>DD</sub> + 0.3 V | V  |
| V <sub>IL</sub>  | Input LOW Voltage ENABLEx, XTAL_IN/CLK                | -0.3                  |    | 0.8                     | V  |
| V <sub>OH</sub>  | Output HIGH Voltage (Note 4)                          | V <sub>DDO</sub> -0.3 |    |                         | V  |
| V <sub>OL</sub>  | Output LOW Voltage (Note 4)                           |                       |    | 0.35                    | V  |
| C <sub>IN</sub>  | Input Capacitance                                     |                       | 4  |                         | pF |
| C <sub>PD</sub>  | Power Dissipation Capacitance (per Output) (Note 4)   |                       | 16 |                         | pF |
| R <sub>OUT</sub> | Output Impedance (Note 4)                             |                       | 10 |                         | Ω  |

**V<sub>DD</sub> = 2.375 V to 2.625 V (2.5 V ± 5%); V<sub>DDO</sub> = 1.6 V to 2.0 V (1.8 V ± 0.2 V); GND = 0 V, T<sub>A</sub> = -40°C to +85°C**

|                  |                                                       |                       |    |                         |    |
|------------------|-------------------------------------------------------|-----------------------|----|-------------------------|----|
| IDD              | Core Quiescent Power Supply Current (ENABLEx = LOW)   |                       |    | 8                       | mA |
| IDDO             | Output Quiescent Power Supply Current (ENABLEx = LOW) |                       |    | 3                       | mA |
| V <sub>IH</sub>  | Input HIGH Voltage ENABLEx, XTAL_IN/CLK               | 1.7                   |    | V <sub>DD</sub> + 0.3 V | V  |
| V <sub>IL</sub>  | Input LOW Voltage ENABLEx, XTAL_IN/CLK                | -0.3                  |    | 0.7                     | V  |
| V <sub>OH</sub>  | Output HIGH Voltage (Note 4)                          | V <sub>DDO</sub> -0.3 |    |                         | V  |
| V <sub>OL</sub>  | Output LOW Voltage (Note 4)                           |                       |    | 0.35                    | V  |
| C <sub>IN</sub>  | Input Capacitance                                     |                       | 4  |                         | pF |
| C <sub>PD</sub>  | Power Dissipation Capacitance (per Output) (Note 4)   |                       | 16 |                         | pF |
| R <sub>OUT</sub> | Output Impedance (Note 4)                             |                       | 10 |                         | Ω  |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

4. Parallel terminated 50 Ω to V<sub>DDO</sub>/2 (see Figure 5).

Table 7. AC CHARACTERISTICS

| Symbol                                                                                                                        | Characteristic                                                                                                                            | Min | Typ                          | Max | Unit   |
|-------------------------------------------------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------|-----|------------------------------|-----|--------|
| <b>V<sub>DD</sub> = V<sub>DDO</sub> = 3.135 V to 3.465 V (3.3 V ± 5%); GND = 0 V, T<sub>A</sub> = -40°C to +85°C (Note 5)</b> |                                                                                                                                           |     |                              |     |        |
| F <sub>max</sub>                                                                                                              | Input Frequency Crystal                                                                                                                   | 3   |                              | 40  | MHz    |
|                                                                                                                               | Input Frequency Clock (XTAL_IN/CLK)                                                                                                       | DC  |                              | 100 |        |
| t <sub>EN</sub> / t <sub>DIS</sub>                                                                                            | Delay for Output Enable / Disable Time ENABLEx to BCLKn                                                                                   |     |                              | 4   | Cycles |
| tSKEW <sub>DC</sub>                                                                                                           | Duty Cycle Skew (See Figure 4)                                                                                                            | 48  |                              | 52  | %      |
| tSKEW <sub>O-O</sub>                                                                                                          | Output to Output Skew Within A Device (same conditions)                                                                                   | 0   | 50                           | 80  | ps     |
| ΦNOISE                                                                                                                        | Phase-Noise Performance f <sub>out</sub> = 25 MHz<br>100 Hz off Carrier<br>1 kHz off Carrier<br>10 kHz off Carrier<br>100 kHz off Carrier |     | -123<br>-142<br>-153<br>-164 |     | dBc/Hz |
| tJIT(Φ)                                                                                                                       | RMS Phase Jitter<br>25 MHz carrier, Integration Range 12 kHz to 20 MHz<br>25 MHz carrier, Integration Range 100 Hz to 1 MHz               |     | 0.08<br>0.08                 |     |        |
| tr/tf                                                                                                                         | Output rise and fall times (20%; 80%)                                                                                                     | 200 |                              | 800 | ps     |

**V<sub>DD</sub> = V<sub>DDO</sub> = 2.375 V to 2.625 V (2.5 V ± 5%); GND = 0 V, T<sub>A</sub> = -40°C to +85°C (Note 5)**

|                                    |                                                                                                                                           |     |                              |     |        |
|------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------|-----|------------------------------|-----|--------|
| F <sub>max</sub>                   | Input Frequency Crystal                                                                                                                   | 3   |                              | 40  | MHz    |
|                                    | Input Frequency Clock (XTAL1)                                                                                                             | DC  |                              | 100 |        |
| t <sub>EN</sub> / t <sub>DIS</sub> | Delay for Output Enable / Disable Time ENABLEx to BCLKn                                                                                   |     |                              | 4   | Cycles |
| tSKEW <sub>DC</sub>                | Duty Cycle Skew (See Figure 4)                                                                                                            | 47  |                              | 53  | %      |
| tSKEW <sub>O-O</sub>               | Output to Output Skew Within A Device (same conditions)                                                                                   | 0   | 50                           | 80  | ps     |
| ΦNOISE                             | Phase-Noise Performance f <sub>out</sub> = 25 MHz<br>100 Hz off Carrier<br>1 kHz off Carrier<br>10 kHz off Carrier<br>100 kHz off Carrier |     | -118<br>-137<br>-151<br>-165 |     | dBc/Hz |
| tJIT(Φ)                            | RMS Phase Jitter<br>25 MHz carrier, Integration Range 12 kHz to 20 MHz<br>25 MHz carrier, Integration Range 100 Hz to 1 MHz               |     | 0.13<br>0.13                 |     |        |
| tr/tf                              | Output rise and fall times (20%; 80%)                                                                                                     | 200 |                              | 800 | ps     |

**V<sub>DD</sub> = V<sub>DDO</sub> = 1.6 V to 2.0 V (1.8 V ± 0.2 V); GND = 0 V, T<sub>A</sub> = -40°C to +85°C (Note 5)**

|                                    |                                                                                                                                           |     |                              |     |        |
|------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------|-----|------------------------------|-----|--------|
| F <sub>max</sub>                   | Input Frequency Crystal                                                                                                                   | 3   |                              | 40  | MHz    |
|                                    | Input Frequency Clock (XTAL1)                                                                                                             | DC  |                              | 100 |        |
| t <sub>EN</sub> / t <sub>DIS</sub> | Delay for Output Enable / Disable Time ENABLEx to BCLKn                                                                                   |     |                              | 4   | Cycles |
| tSKEW <sub>DC</sub>                | Duty Cycle Skew (See Figure 4)                                                                                                            | 47  |                              | 53  | %      |
| tSKEW <sub>O-O</sub>               | Output to Output Skew Within A Device (same conditions)                                                                                   | 0   | 50                           | 80  | ps     |
| ΦNOISE                             | Phase-Noise Performance f <sub>out</sub> = 25 MHz<br>100 Hz off Carrier<br>1 kHz off Carrier<br>10 kHz off Carrier<br>100 kHz off Carrier |     | -129<br>-145<br>-147<br>-157 |     | dBc/Hz |
| tJIT(Φ)                            | RMS Phase Jitter<br>25 MHz carrier, Integration Range 12 kHz to 20 MHz<br>25 MHz carrier, Integration Range 100 Hz to 1 MHz               |     | 0.27<br>0.27                 |     |        |
| tr/tf                              | Output rise and fall times (20%; 80%)                                                                                                     | 200 |                              | 900 | ps     |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

5. Crystal inputs ≤ F<sub>max</sub>. Outputs loaded with 50 Ω to V<sub>DDO</sub>/2. CLOCK (LVCMOS levels at XTAL1 input) 50% duty cycle. See Figures 4 and 7. See APPLICATION INFORMATION; Crystal Input Interface for CL loading.

Table 7. AC CHARACTERISTICS (continued)

| Symbol                                                                                                                                                         | Characteristic                                                                                                                            | Min | Typ                          | Max | Unit   |
|----------------------------------------------------------------------------------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------|-----|------------------------------|-----|--------|
| <b>V<sub>DD</sub> = 3.135 V to 3.465 V (3.3 V ± 5%); V<sub>DDO</sub> = 2.375 V to 2.625 V (2.5 V ± 5%); GND = 0 V, T<sub>A</sub> = -40°C to +85°C (Note 5)</b> |                                                                                                                                           |     |                              |     |        |
| F <sub>max</sub>                                                                                                                                               | Input Frequency Crystal                                                                                                                   | 3   |                              | 40  | MHz    |
|                                                                                                                                                                | Input Frequency Clock (XTAL_IN/CLK)                                                                                                       | DC  |                              | 100 |        |
| t <sub>EN</sub> / t <sub>DIS</sub>                                                                                                                             | Delay for Output Enable / Disable Time ENABLEx to BCLKn                                                                                   |     |                              | 4   | Cycles |
| tSKEW <sub>DC</sub>                                                                                                                                            | Duty Cycle Skew (See Figure 4)                                                                                                            | 48  |                              | 52  | %      |
| tSKEW <sub>O-O</sub>                                                                                                                                           | Output to Output Skew Within A Device (same conditions)                                                                                   | 0   | 50                           | 80  | ps     |
| ΦNOISE                                                                                                                                                         | Phase-Noise Performance f <sub>out</sub> = 25 MHz<br>100 Hz off Carrier<br>1 kHz off Carrier<br>10 kHz off Carrier<br>100 kHz off Carrier |     | -129<br>-145<br>-147<br>-157 |     | dBc/Hz |
| tJIT(Φ)                                                                                                                                                        | RMS Phase Jitter<br>25 MHz carrier, Integration Range 12 kHz to 20 MHz<br>25 MHz carrier, Integration Range 100 Hz to 1 MHz               |     | 0.14<br>0.14                 |     |        |
| tr/tf                                                                                                                                                          | Output rise and fall times (20%; 80%)                                                                                                     | 200 |                              | 800 | ps     |

**V<sub>DD</sub> = 3.135 V to 3.465 V (3.3 V ± 5%); V<sub>DDO</sub> = 1.6 V to 2.0 V (1.8 V ± 0.2 V); GND = 0 V, T<sub>A</sub> = -40°C to +85°C (Note 5)**

|                                    |                                                                                                                                           |     |                              |     |        |
|------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------|-----|------------------------------|-----|--------|
| F <sub>max</sub>                   | Input Frequency Crystal                                                                                                                   | 3   |                              | 40  | MHz    |
|                                    | Input Frequency Clock (XTAL1)                                                                                                             | DC  |                              | 100 |        |
| t <sub>EN</sub> / t <sub>DIS</sub> | Delay for Output Enable / Disable Time ENABLEx to BCLKn                                                                                   |     |                              | 4   | Cycles |
| tSKEW <sub>DC</sub>                | Duty Cycle Skew (See Figure 4)                                                                                                            | 48  |                              | 52  | %      |
| tSKEW <sub>O-O</sub>               | Output to Output Skew Within A Device (same conditions)                                                                                   | 0   | 50                           | 80  | ps     |
| ΦNOISE                             | Phase-Noise Performance f <sub>out</sub> = 25 MHz<br>100 Hz off Carrier<br>1 kHz off Carrier<br>10 kHz off Carrier<br>100 kHz off Carrier |     | -129<br>-145<br>-147<br>-157 |     | dBc/Hz |
| tJIT(Φ)                            | RMS Phase Jitter<br>25 MHz carrier, Integration Range 12 kHz to 20 MHz<br>25 MHz carrier, Integration Range 100 Hz to 1 MHz               |     | 0.18<br>0.18                 |     |        |
| tr/tf                              | Output rise and fall times (20%; 80%)                                                                                                     | 200 |                              | 900 | ps     |

**V<sub>DD</sub> = 2.375 V to 2.625 V (2.5 V ± 5%); V<sub>DDO</sub> = 1.6 V to 2.0 V (1.8 V ± 0.2 V); GND = 0 V, T<sub>A</sub> = -40°C to +85°C (Note 5)**

|                                    |                                                                                                                                            |     |                              |     |        |
|------------------------------------|--------------------------------------------------------------------------------------------------------------------------------------------|-----|------------------------------|-----|--------|
| F <sub>max</sub>                   | Input Frequency Crystal                                                                                                                    | 3   |                              | 40  | MHz    |
|                                    | Input Frequency Clock (XTAL1)                                                                                                              | DC  |                              | 100 |        |
| t <sub>EN</sub> / t <sub>DIS</sub> | Delay for Output Enable / Disable Time ENABLEx to BCLKn                                                                                    |     |                              | 4   | Cycles |
| tSKEW <sub>DC</sub>                | Duty Cycle Skew (See Figure 4)                                                                                                             | 47  |                              | 53  | %      |
| tSKEW <sub>O-O</sub>               | Output to Output Skew Within A Device (same conditions)                                                                                    | 0   | 50                           | 80  | ps     |
| ΦNOISE                             | Phase-Noise Performance f <sub>out</sub> = 25 MHz/<br>100 Hz off Carrier<br>1 kHz off Carrier<br>10 kHz off Carrier<br>100 kHz off Carrier |     | -129<br>-145<br>-147<br>-157 |     | dBc/Hz |
| tJIT(Φ)                            | RMS Phase Jitter<br>25 MHz carrier, Integration Range 12 kHz to 20 MHz<br>25 MHz carrier, Integration Range 100 Hz to 1 MHz                |     | 0.19<br>0.19                 |     |        |
| tr/tf                              | Output rise and fall times (20%; 80%)                                                                                                      | 200 |                              | 900 | ps     |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

5. Crystal inputs ≤ F<sub>max</sub>. Outputs loaded with 50 Ω to V<sub>DDO</sub>/2. CLOCK (LVCMOS levels at XTAL1 input) 50% duty cycle. See Figures 4 and 7. See APPLICATION INFORMATION; Crystal Input Interface for CL loading.

# NB3H83905C

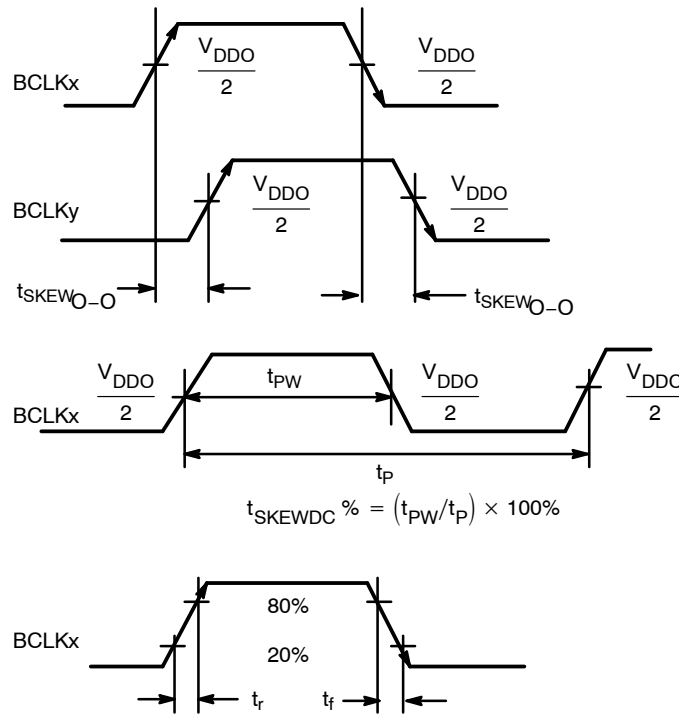


Figure 4. AC Reference Measurement

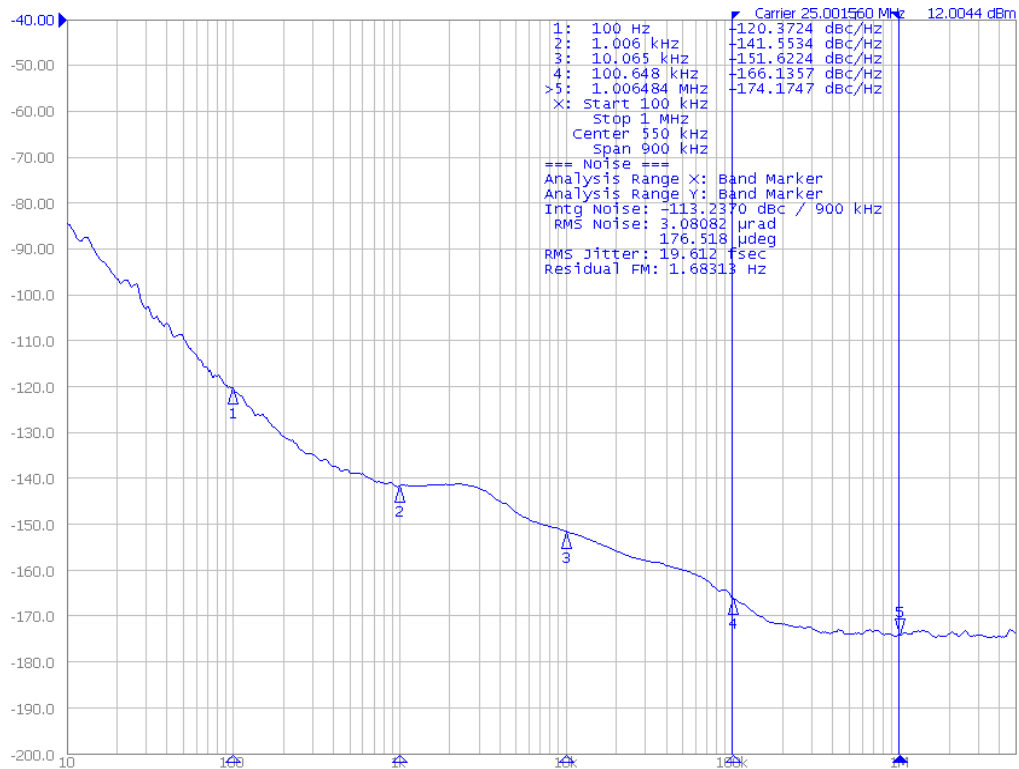


Figure 5. Typical Phase Noise Plot of the NB3H83905C Operating at 25 MHz  $V_{DD} = V_{DDO} = 3.3$  V

## NB3H83905C

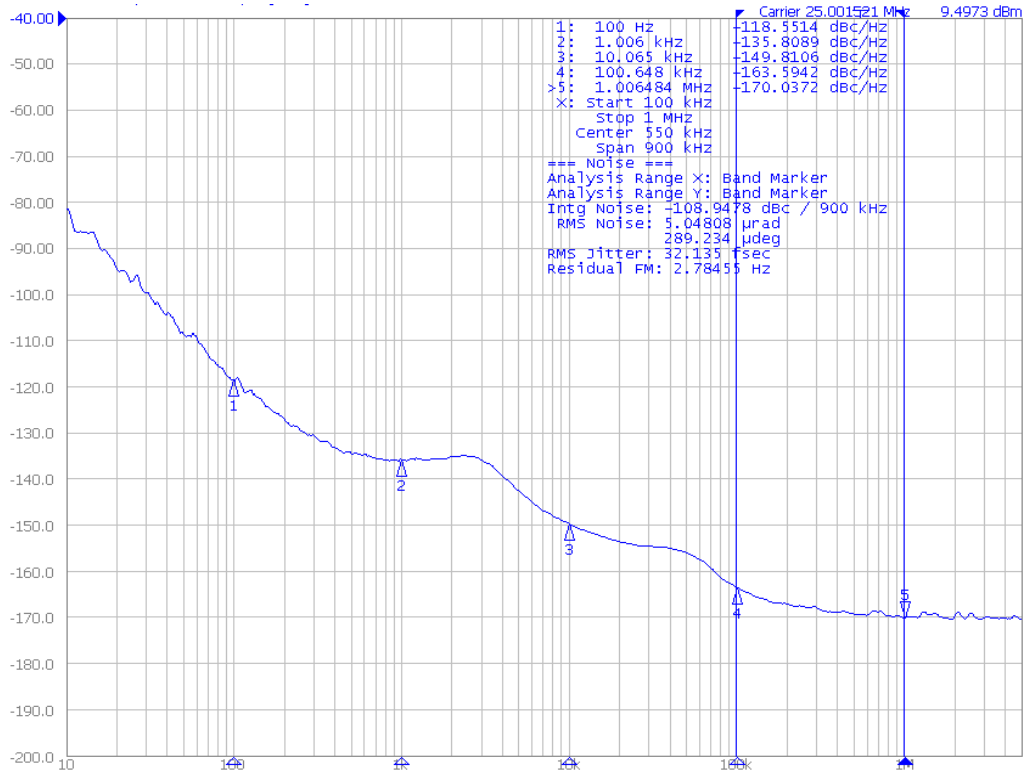


Figure 6. Typical Phase Noise Plot of the NB3H83905C Operating at 25 MHz  $V_{DD} = V_{DDO} = 2.5$  V

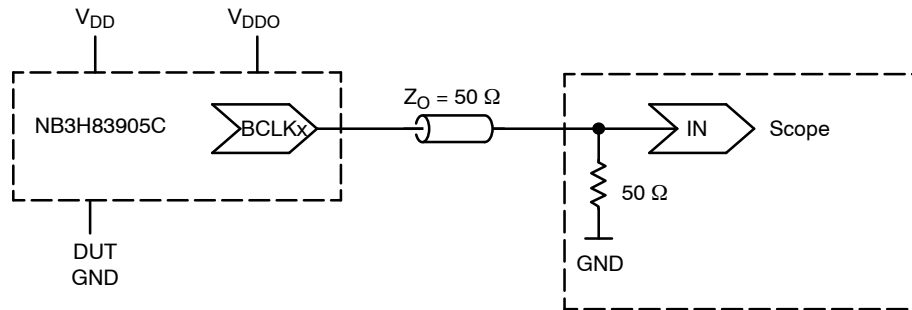


Figure 7. Typical Device Evaluation and Termination Setup – See Table 8

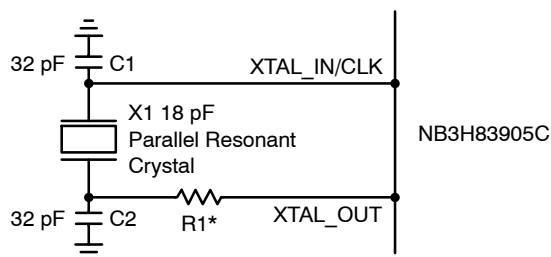
**Table 8. TEST SUPPLY SETUP.  $V_{DDO}$  SUPPLY MAY BE CENTERED ON 0.0 V (SCOPE GND) TO PERMIT DIRECT CONNECTION INTO “50  $\Omega$  TO GND” SCOPE MODULE.  $V_{DD}$  SUPPLY TRACKS DUT GND PIN**

| Spec Condition:                                                                                                  | Test Setup $V_{DD}$ : | Test Setup $V_{DDO}$ : | Test Setup DUT GND:  |
|------------------------------------------------------------------------------------------------------------------|-----------------------|------------------------|----------------------|
| $V_{DD} = V_{DDO} = 3.135$ V to $3.465$ V ( $3.3$ V $\pm 5\%$ )                                                  | 1.56 to 1.73 V        | 1.56 to 1.73 V         | -1.56 to -1.73 V     |
| $V_{DD} = V_{DDO} = 2.375$ V to $2.625$ V ( $2.5$ V $\pm 5\%$ )                                                  | 1.1875 to 1.3125 V    | 1.1875 to 1.3125 V     | -1.1875 to -1.3125 V |
| $V_{DD} = V_{DDO} = 1.6$ V to $2.0$ V ( $1.8$ V $\pm 0.2$ V)                                                     | 0.8 to 1.0 V          | 0.8 to 1.0 V           | -0.8 to -1.0 V       |
| $V_{DD} = 3.135$ V to $3.465$ V ( $3.3$ V $\pm 5\%$ );<br>$V_{DDO} = 2.375$ V to $2.625$ V ( $2.5$ V $\pm 5\%$ ) | 1.955 to 2.1525 V     | 1.1875 to 1.3125 V     | -1.1875 to -1.3125 V |
| $V_{DD} = 3.135$ V to $3.465$ V ( $3.3$ V $\pm 5\%$ );<br>$V_{DDO} = 1.6$ V to $2.0$ V ( $1.8$ V $\pm 0.2$ V)    | 2.335 to 2.465 V      | 0.8 to 1.0 V           | -0.8 to -1.0 V       |
| $V_{DD} = 2.375$ V to $2.625$ V ( $2.5$ V $\pm 5\%$ );<br>$V_{DDO} = 1.6$ V to $2.0$ V ( $1.8$ V $\pm 0.2$ V)    | 1.575 to 1.625 V      | 0.8 to 1.0 V           | -0.8 to -1.0 V       |

## APPLICATION INFORMATION

### Crystal Input Interface

Figure 8 shows the NB3H83905C device crystal oscillator interface using a typical parallel resonant crystal. A parallel crystal with loading capacitance  $C_L = 18$  pF would use  $C1 = 32$  pF and  $C2 = 32$  pF as nominal values, assuming 4 pF of stray cap per line. The frequency accuracy and duty cycle skew can be fine tuned by adjusting the  $C1$  and  $C2$  values. For example, increasing the  $C1$  and  $C2$  values will reduce the operational frequency. Note  $R1$  is optional and may be 0  $\Omega$ .



**Figure 8. NB3H83905C Crystal Oscillator Interface**  
\*  $R1$  is optional

### Termination

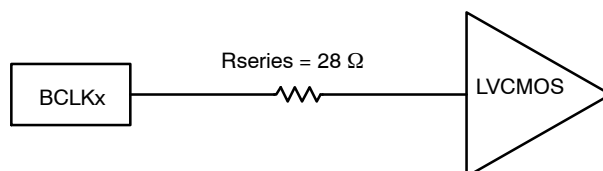
NB3H83905C device output series termination may be used by locating a 28  $\Omega$  series resistor at the driver pin as shown in Figure 9. Alternatively, a Thevenin Parallel termination may be used by locating a 100  $\Omega$  pullup resistor to  $V_{DD}$  and a 100  $\Omega$  pullup resistor to GND at the receiver pin, instead of an  $R_s$  source termination resistor, Figure 10.

### Unused Input and Output Pins

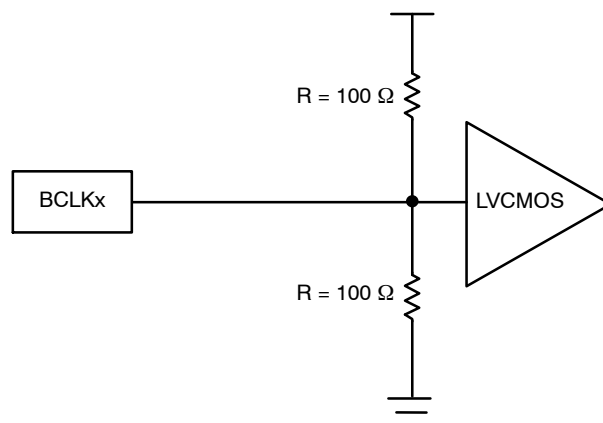
All LVCMOS control pins have internal pull-ups or pull-downs; additional external resistors are not required (optionally 1 k $\Omega$  resistors may be used). All unused LVCMOS outputs can be left floating with no trace attached.

### Bypass

The  $V_{DD}$  and  $V_{DDO}$  supply pins should be bypassed with both a 10  $\mu$ F and a 0.1  $\mu$ F cap from supply pins to GND.



**Figure 9. Series Termination**



**Figure 10. Optional Thevenin Termination**

## ORDERING INFORMATION

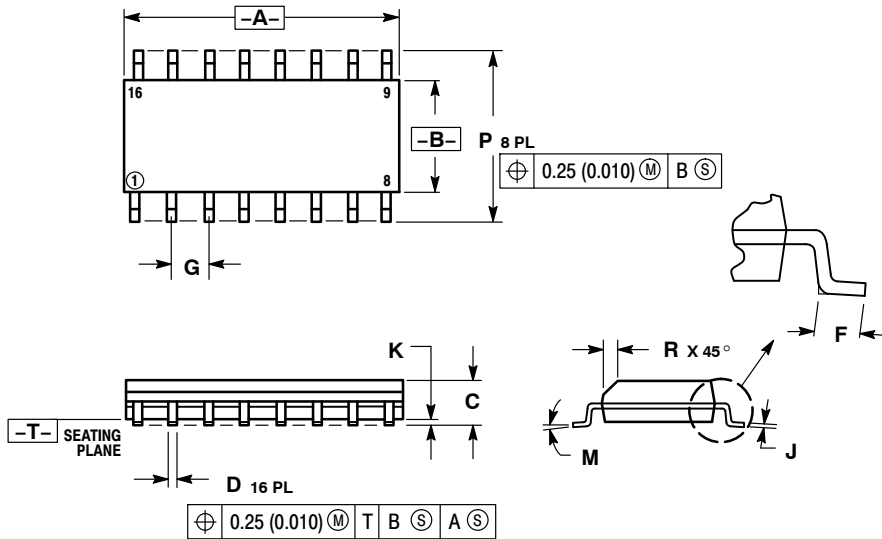
| Device          | Package               | Shipping†                |
|-----------------|-----------------------|--------------------------|
| NB3H83905CDG    | SOIC-16<br>(Pb-Free)  | 48 Units / Rail          |
| NB3H83905CDR2G  | SOIC-16<br>(Pb-Free)  | 2500 Units / Tape & Reel |
| NB3H83905CDTG   | TSSOP-16<br>(Pb-Free) | 96 Units / Rail          |
| NB3H83905CDTR2G | TSSOP-16<br>(Pb-Free) | 2500 Units / Tape & Reel |
| NB3H83905CMNG   | QFN-20<br>(Pb-Free)   | 92 Units / Rail          |
| NB3H83905CMNTXG | QFN-20<br>(Pb-Free)   | 3000 / Tape & Reel       |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# NB3H83905C

## PACKAGE DIMENSIONS

SOIC-16  
CASE 751B-05  
ISSUE K

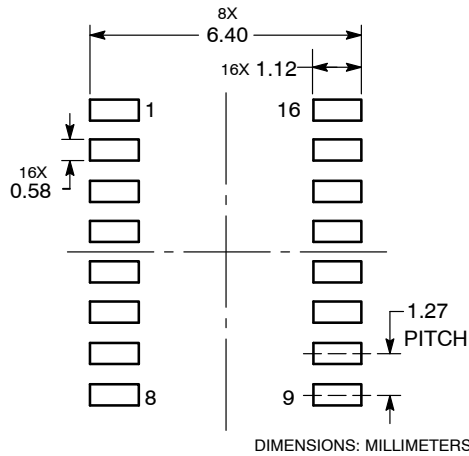


### NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION.
4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.

| DIM | MILLIMETERS |       | INCHES    |       |
|-----|-------------|-------|-----------|-------|
|     | MIN         | MAX   | MIN       | MAX   |
| A   | 9.80        | 10.00 | 0.386     | 0.393 |
| B   | 3.80        | 4.00  | 0.150     | 0.157 |
| C   | 1.35        | 1.75  | 0.054     | 0.068 |
| D   | 0.35        | 0.49  | 0.014     | 0.019 |
| F   | 0.40        | 1.25  | 0.016     | 0.049 |
| G   | 1.27 BSC    |       | 0.050 BSC |       |
| J   | 0.19        | 0.25  | 0.008     | 0.009 |
| K   | 0.10        | 0.25  | 0.004     | 0.009 |
| M   | 0°          | 7°    | 0°        | 7°    |
| P   | 5.80        | 6.20  | 0.229     | 0.244 |
| R   | 0.25        | 0.50  | 0.010     | 0.019 |

### SOLDERING FOOTPRINT\*



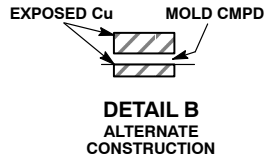
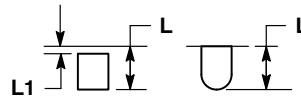
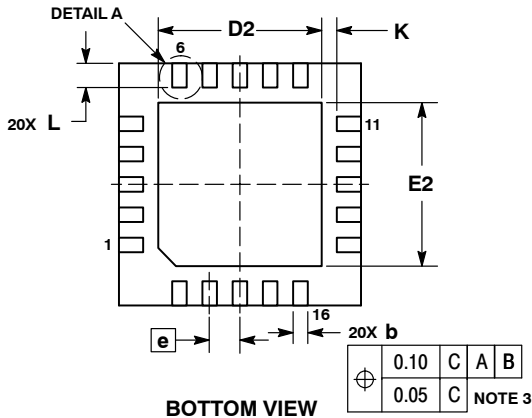
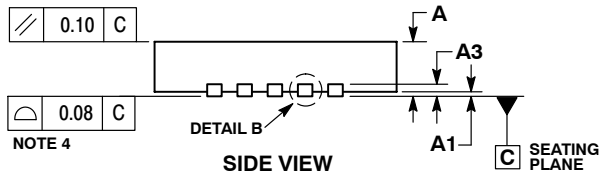
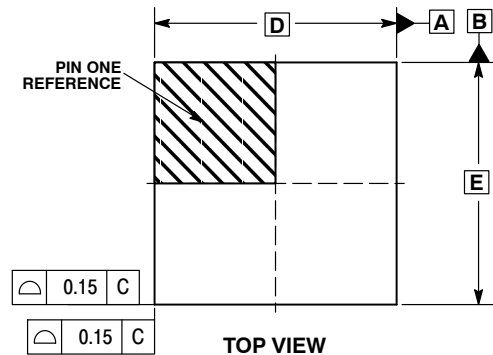
\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.



# NB3H83905C

## PACKAGE DIMENSIONS

QFN20 4x4, 0.5P  
CASE 485BH  
ISSUE O

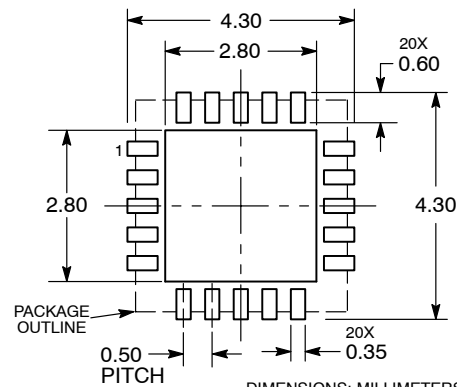


### NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 MM FROM TERMINAL TIP.
4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

| DIM | MILLIMETERS |      |
|-----|-------------|------|
|     | MIN         | MAX  |
| A   | 0.80        | 1.00 |
| A1  | ---         | 0.05 |
| A3  | 0.20 REF    |      |
| b   | 0.20        | 0.30 |
| D   | 4.00 BSC    |      |
| D2  | 2.60        | 2.80 |
| E   | 4.00 BSC    |      |
| E2  | 2.60        | 2.80 |
| e   | 0.50 BSC    |      |
| K   | 0.20        | ---  |
| L   | 0.35        | 0.45 |
| L1  | 0.00        | 0.15 |

### MOUNTING FOOTPRINT\*



DIMENSIONS: MILLIMETERS

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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NB3H83905C/D

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